Application/Control No. 10/562,816	Applicant(s)/Patent Under Reexamination NAKANO ET AL.		
Examiner	Art Unit		
SHIN-HON CHEN	2431	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,442,689	08-2002	Kocher, Paul Carl	713/158
*	В	US-7,370,212	05-2008	Bourne et al.	713/193
*	O	US-2005/0021969	01-2005	Williams et al.	713/176
*	D	US-2003/0212888	11-2003	Wildish et al.	713/158
*	Е	US-2002/0053023	05-2002	Patterson et al.	713/156
	F	US-			
	O	US-		-	
	Ξ	US-			
	-	US-			
	7	US-			
	к	US-			
	٦	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	The state of the s	
	v		
	w		
	×		

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.